

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/080,067	WARIISHI ET AL.	
Examiner	Art Unit	
Robert Hodge	1746	

	SEARCHED					
Class	Subclass	Date	Examiner			
429	313,317	1-4-05	Rutt			
	306,129					
	188,323					
	345, 312					
	213, 314					
	218.1, 303					
	307,308					
	144, 33					
252	62.2					
	299.61					
	512					
136	263					
29	623.5					
525	331.9	Ψ				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
429	313 & 317	1/4/2005			
429	188	1/4/2005			
		T.			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted Jonathan Crepeau Re: Prior Art and Search Strategy	12/30/04	Rwil		
Consulted Joseph Perrin Re: Basic Polymer Structure	1/3/2005	Ruil		
Consulted Jonathan Crepeau Re: Allowable Subject Matter	1/3/2005	Rwil		
Consulted Bruce Bell Re: Allowable Subject Matter	1/4/2005	RuH		
Inventor Search See attached East Search History	12/30/2004	Ruit		
See Attached East Search History	1/4/2005	RwH		
See Attached STIC Search Report	12/31/2004	RuH		
Plus Search	1-3-05	RVH		